Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/695,803	SARWARY ET AL.	
Examiner	Art Unit	
Sun J. Lin	2825	

	SEAR	CHED	
Class	Subclass	Date	Examiner
716	1	10/4/2005	JSL
716	4	10/4/2005	JSL
716	5	10/4/2005	JSL
716	6	10/4/2005	JSL
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INI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/4/2005	JSL	
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/18/2005	JSL	
IEEE	10/4/2005	JSL	
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